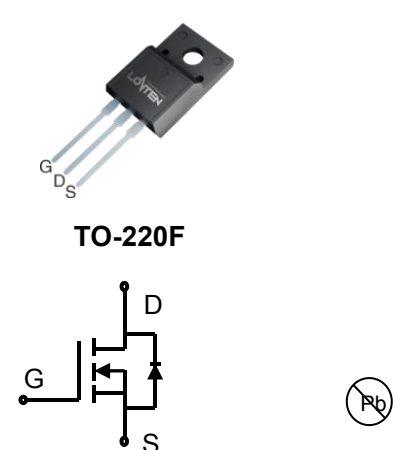


Lonten N-channel 650V, 11A¹⁾, 0.38Ω LonFET™ Power MOSFET

<p>Description</p> <p>LonFET™ Power MOSFET is fabricated using advanced super junction technology. The resulting device has extremely low on resistance, making it especially suitable for applications which require superior power density and outstanding efficiency.</p> <p>Features</p> <ul style="list-style-type: none"> ◆ Ultra low $R_{DS(on)}$ ◆ Ultra low gate charge (typ. $Q_g = 21\text{nC}$) ◆ 100% UIS tested ◆ RoHS compliant <p>Applications</p> <ul style="list-style-type: none"> ◆ Power factor correction (PFC). ◆ Switched mode power supplies (SMPS). ◆ Uninterruptible power supply (UPS). 	<p>Product Summary</p> <table> <tr> <td>$V_{DS} @ T_{j,max}$</td><td>700V</td></tr> <tr> <td>$R_{DS(on),max}$</td><td>0.38Ω</td></tr> <tr> <td>I_{DM}</td><td>18A</td></tr> <tr> <td>$Q_{g,typ}$</td><td>21nC</td></tr> </table> <p>Pin Configuration</p>  <p>TO-220F</p> <p>N-Channel MOSFET</p>	$V_{DS} @ T_{j,max}$	700V	$R_{DS(on),max}$	0.38Ω	I_{DM}	18A	$Q_{g,typ}$	21nC
$V_{DS} @ T_{j,max}$	700V								
$R_{DS(on),max}$	0.38Ω								
I_{DM}	18A								
$Q_{g,typ}$	21nC								

Absolute Maximum Ratings

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DSS}	650	V
Continuous drain current ($T_C = 25^\circ\text{C}$)	I_D	6	A
($T_C = 100^\circ\text{C}$)		3.8	A
Pulsed drain current ²⁾	I_{DM}	18	A
Gate-Source voltage	V_{GSS}	± 30	V
Avalanche energy, single pulse ³⁾	E_{AS}	270	mJ
Power Dissipation	P_D	30	W
Operating and Storage Temperature Range	T_J, T_{STG}	-55 to +150	$^\circ\text{C}$
Continuous diode forward current	I_S	6	A
Diode pulse current	$I_{S,pulse}$	18	A

Thermal Characteristics

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	4.2	$^\circ\text{C/W}$
Thermal Resistance, Junction-to-Ambient ⁴⁾	$R_{\theta JA}$	60	$^\circ\text{C/W}$

Package Marking and Ordering Information

Device	Device Package	Marking	Units/Tube
LSD65R380GF	TO-220F	LSD65R380GF	50

Electrical Characteristics
 $T_c = 25^{\circ}\text{C}$ unless otherwise noted

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Static characteristics						
Drain-source breakdown voltage	BV _{DSS}	V _{GS} =0 V, I _D =0.25 mA	650	-	-	V
Gate threshold voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =0.25mA	2.5	3.5	5.0	V
Drain cut-off current	I _{DSS}	V _{DS} =650 V, V _{GS} =0 V, T _J = 25°C	-	-	5	μA
Gate leakage current, Forward	I _{GSSF}	V _{GS} =30 V, V _{DS} =0 V	-	-	100	nA
Gate leakage current, Reverse	I _{GSSR}	V _{GS} =-30 V, V _{DS} =0 V	-	-	-100	nA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} =10 V, I _D =5.5A	-			
		T _J = 25°C	-	0.34	0.38	Ω
		T _J = 150°C	-	0.75	-	
Gate resistance	R _G	f=1 MHz, open drain	-	6	-	Ω
Dynamic characteristics						
Input capacitance	C _{iss}	V _{DS} = 100 V, V _{GS} = 0 V, f = 250 kHz	-	920	-	pF
Output capacitance	C _{oss}		-	35.4	-	
Reverse transfer capacitance	C _{rss}		-	0.86	-	
Turn-on delay time	t _{d(on)}	V _{DD} = 400V, I _D = 5.5A R _G = 10Ω, V _{GS} =10V	-	19.6	-	ns
Rise time	t _r		-	36.5	-	
Turn-off delay time	t _{d(off)}		-	39	-	
Fall time	t _f		-	9.5	-	
Gate charge characteristics						
Gate to source charge	Q _{gs}	V _{DD} =520 V, I _D =5.5A, V _{GS} =0 to 10 V	-	3.6	-	nC
Gate to drain charge	Q _{gd}		-	6.3	-	
Gate charge total	Q _g		-	21	-	
Gate plateau voltage	V _{plateau}		-	4	-	V
Reverse diode characteristics						
Diode forward voltage	V _{SD}	V _{GS} =0 V, I _F =11A	-	-	1.1	V
Reverse recovery time	t _{rr}	V _R =50 V, I _F =11A, dI _F /dt=100 A/μs	-	140	-	ns
Reverse recovery charge	Q _{rr}		-	0.8	-	μC
Peak reverse recovery current	I _{rrm}		-	12	-	A

Notes:

1. The value reference TO-220 package.
2. Limited by maximum junction temperature, maximum duty cycle is 0.75.
3. $I_{AS} = 3\text{ A}$, $L=60\text{ mH}$, $V_{DD} = 60\text{ V}$, Starting $T_j = 25^{\circ}\text{C}$.
4. The value of R_{thJA} is measured by placing the device in a still air box which is one cubic foot.

Electrical Characteristics Diagrams

Figure 1. Typ. Output Characteristics

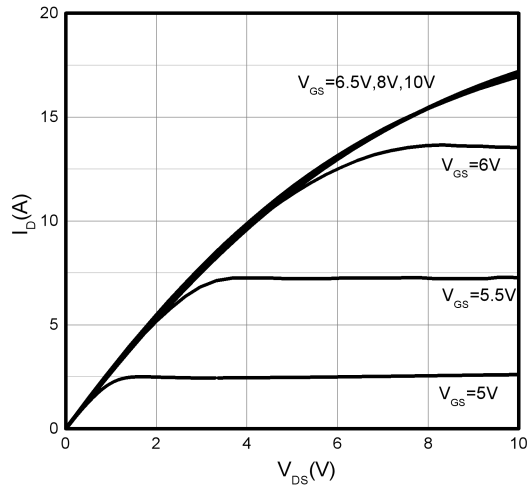


Figure 2. Transfer Characteristics

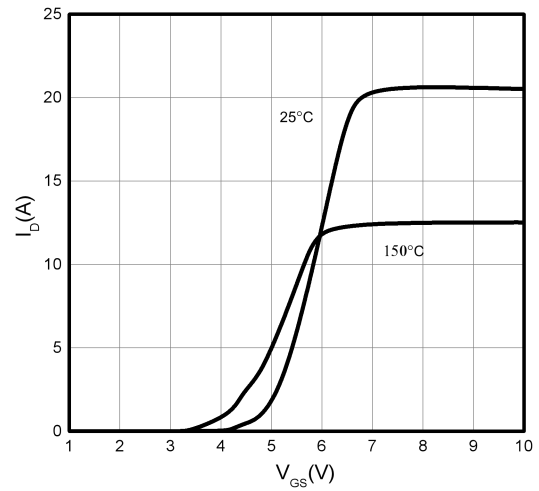


Figure 3. On-Resistance vs. Drain Current

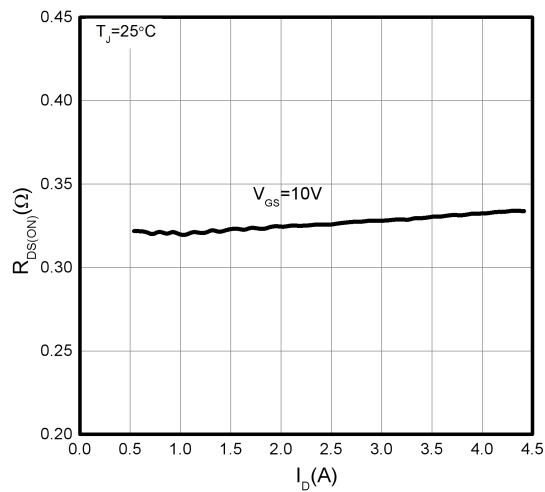


Figure 4. On-Resistance vs. Temperature

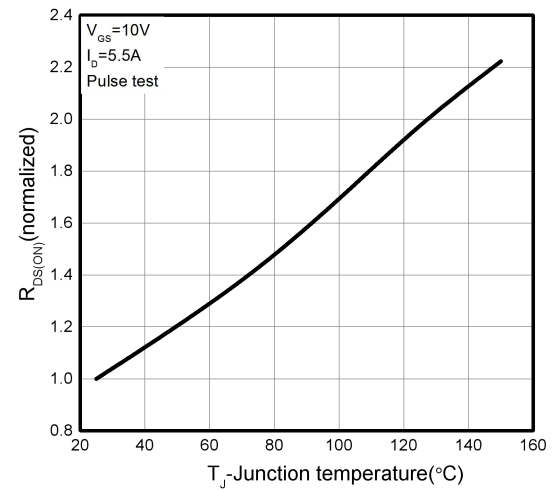


Figure 5. Breakdown Voltage vs. Temperature

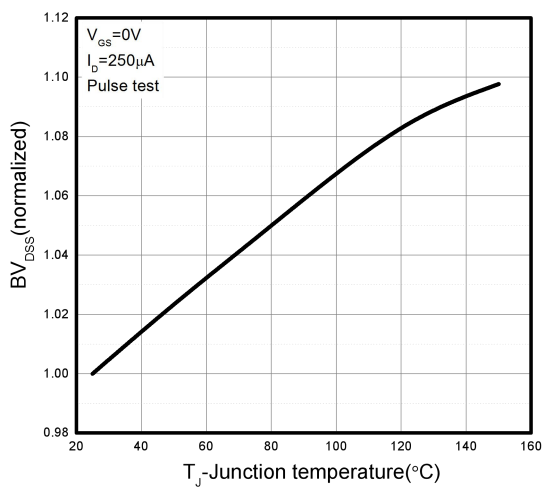


Figure 6. Threshold Voltage vs. Temperature

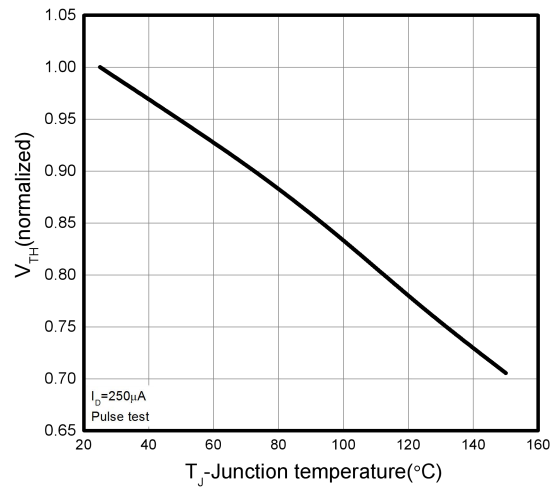


Figure 7.Body-Diode Characteristics

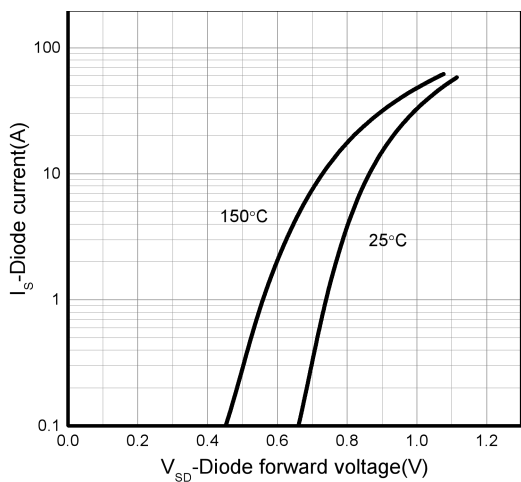


Figure 8.Capacitance Characteristics

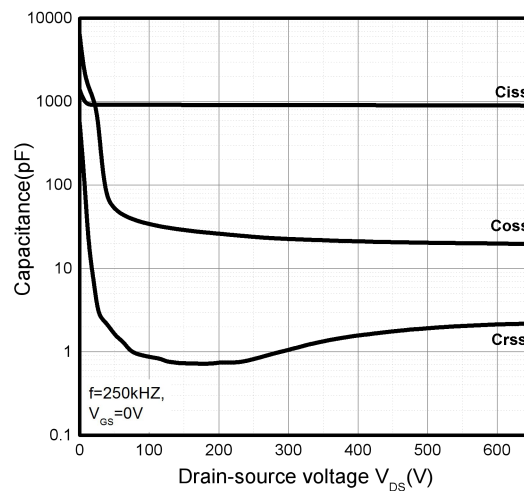


Figure 9.Gate Charge Characteristics

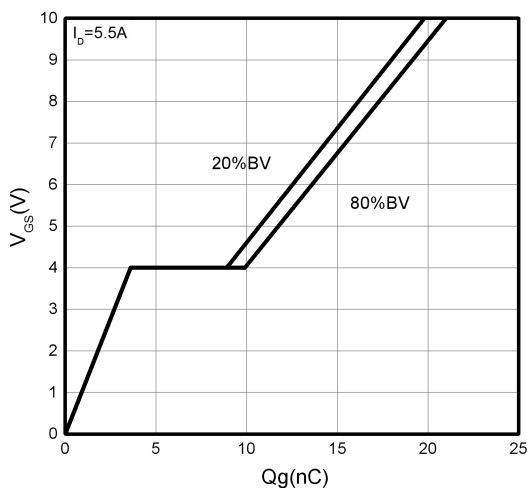


Figure 10.Drain Current Derating

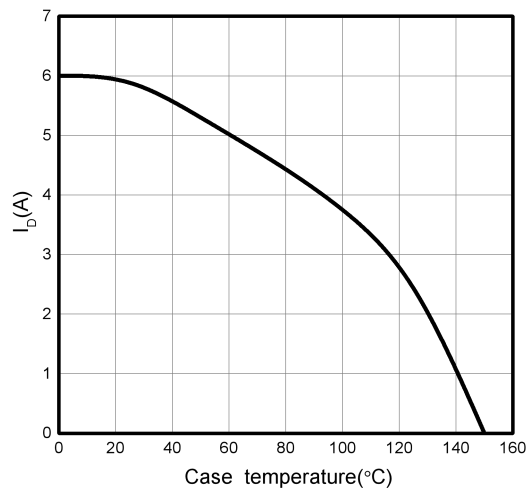


Figure 11.Power Dissipation vs.Temperature

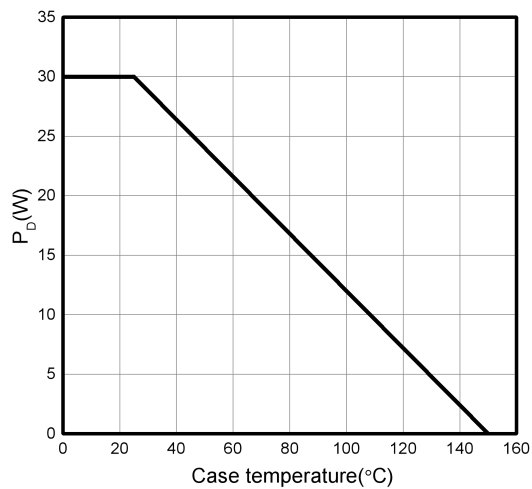


Figure 12. Safe Operating Area

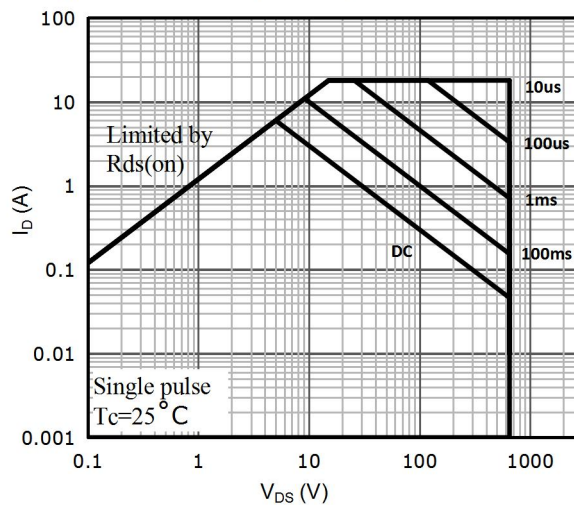
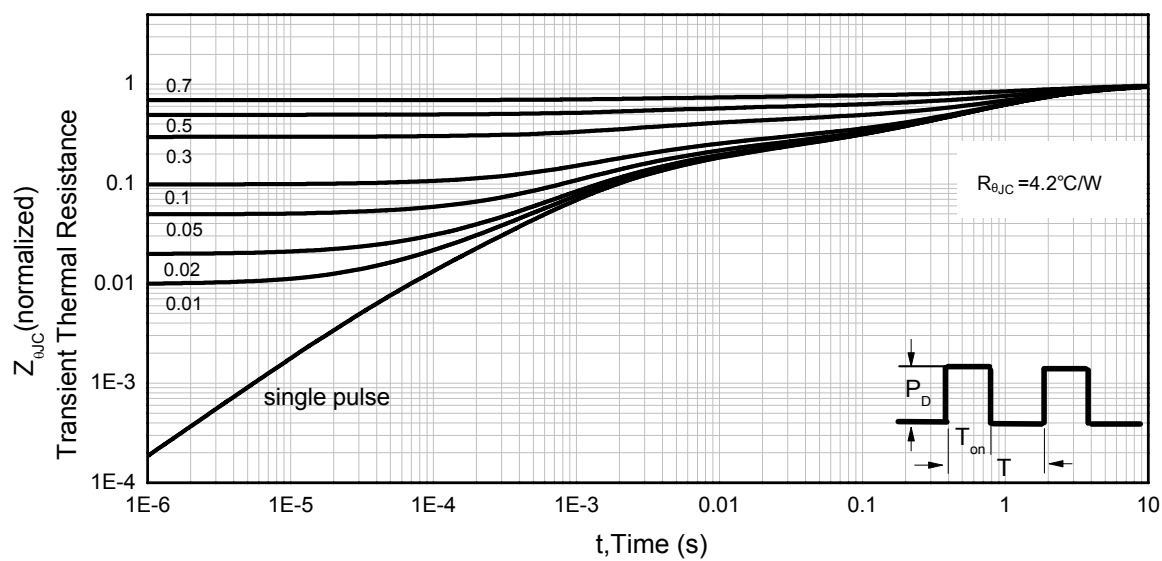
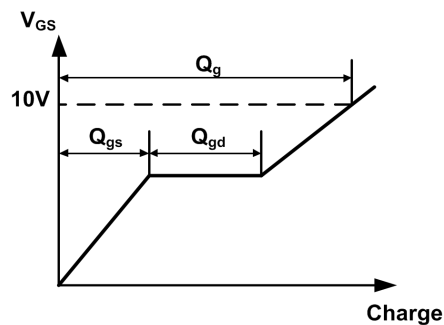
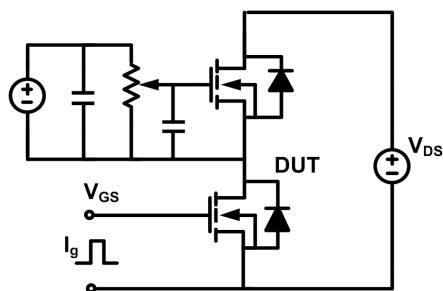


Figure 13. Normalized Maximum Transient Thermal Impedance (R_{thJC})

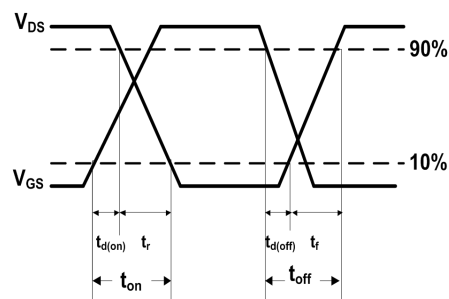
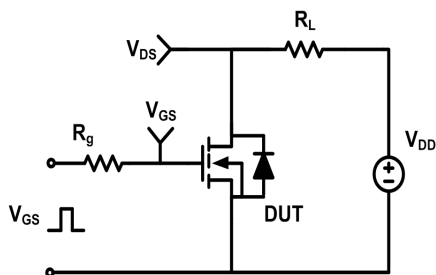


Test Circuit & Waveforms

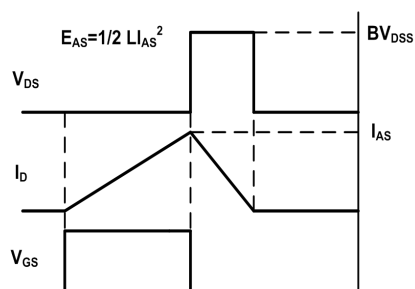
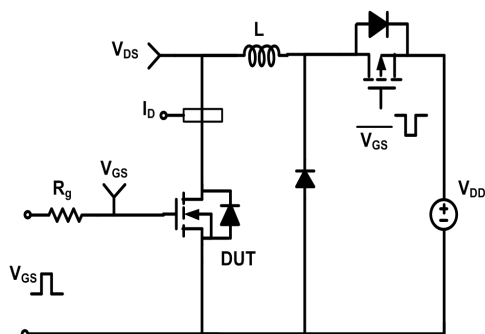
Gate Charge Test Circuit & Waveform



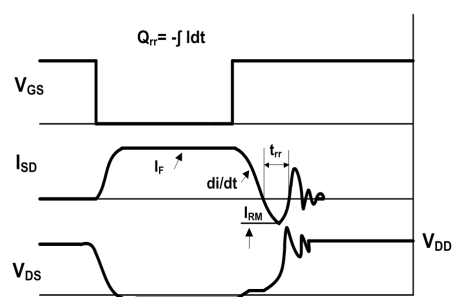
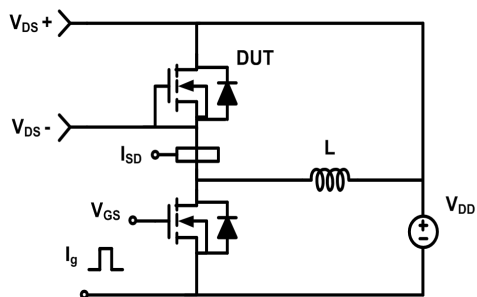
Resistive Switching Test Circuit & Waveform



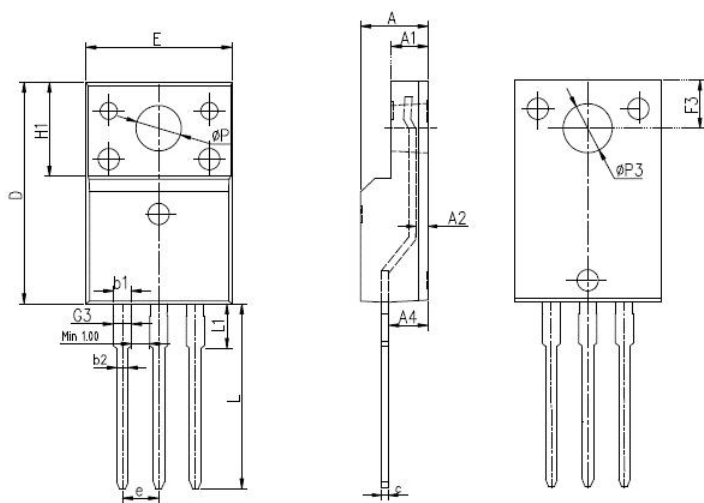
Unclamped Inductive Switching (UIS) Test Circuit & Waveform



Diode Recovery Test Circuit & Waveform



Mechanical Dimensions for TO-220F



DIMENSIONS IN MILLIMETERS		
SYMBOL	MIN	MAX
A	4.4	4.9
A1	2.34	2.74
A2	0.3	0.7
A4	2.5	2.96
c	0.4	0.7
D	15.57	16.4
E	9.96	10.4
H1	6.48	6.95
e	2.54BSC	
L	12.68	14.2
L1	2.88	3.6
ΦP	3	3.38
ΦP3	3.15	3.65
F3	3.15	3.45
G3	1.15	1.58
b1	1.18	1.43
b2	0.7	1

Version Information

LSD65R380GF

Revision:2022-05-12,Rev 1.0

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